Silicon Carbide Schottky Diode

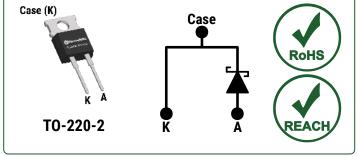


VRRM =	1200 V
F (Tc = 135°C) =	12 A
Qc =	40 nC

Features

- Low V_F for High Temperature Operation
- Enhanced Surge and Avalanche Robustness
- Superior Figure of Merit Q_C/I_F
- Low Thermal Resistance
- Low Reverse Leakage Current
- Temperature Independent Fast Switching
- Positive Temperature Coefficient of V_F
- High dV/dt Ruggedness

Package



Advantages

- Improved System Efficiency
- High System Reliability
- Optimal Price Performance
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

Applications

- Power Factor Correction (PFC)
- Solar Inverters
- Battery Chargers
- High Frequency Converters
- Switched Mode Power Supply (SMPS)
- AC/DC Power Supplies
- Anti-Parallel / Free-Wheeling Diode
- LED and HID Lighting

Absolute Maximum Ratings (At Tc = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage	V _{RRM}		1200	V	
		T _C = 100°C, D = 1	17		
Continuous Forward Current	lF	T _C = 135°C, D = 1	12	Α	Fig. 4
		T _C = 156°C, D = 1	7.5		
Non-Repetitive Peak Forward Surge Current, Half Sine	Irou	T _C = 25°C, t _P = 10 ms	75	А	
Wave	IF,SM	Tc = 150°C, t⊵ = 10 ms	60	A	
Repetitive Peak Forward Surge Current, Half Sine Wave	lenu	T _C = 25°C, t _P = 10 ms	45	А	
Repetitive Feak Forward Suige Current, Han Sine Wave	I _{F,RM}	Tc = 150°C, t⊵ = 10 ms	32	A	
Non-Repetitive Peak Forward Surge Current	I _{F,MAX}	T _C = 25°C, t _P = 10 μs	375	А	
i ² t Value	∫i²dt	T _C = 25°C, t _P = 10 ms	28	A ² s	
Non-Repetitive Avalanche Energy	E _{AS}	L = 4.8 mH, I _{AS} = 7.5 A	135	mJ	
Diode Ruggedness	dV/dt	V _R = 0 ~ 960 V	200	V/ns	
Power Dissipation	Ртот	T _C = 25°C	116	W	Fig. 3
Operating and Storage Temperature	T _j , T _{stg}		-55 to 175	°C	



Electrical Characteristics

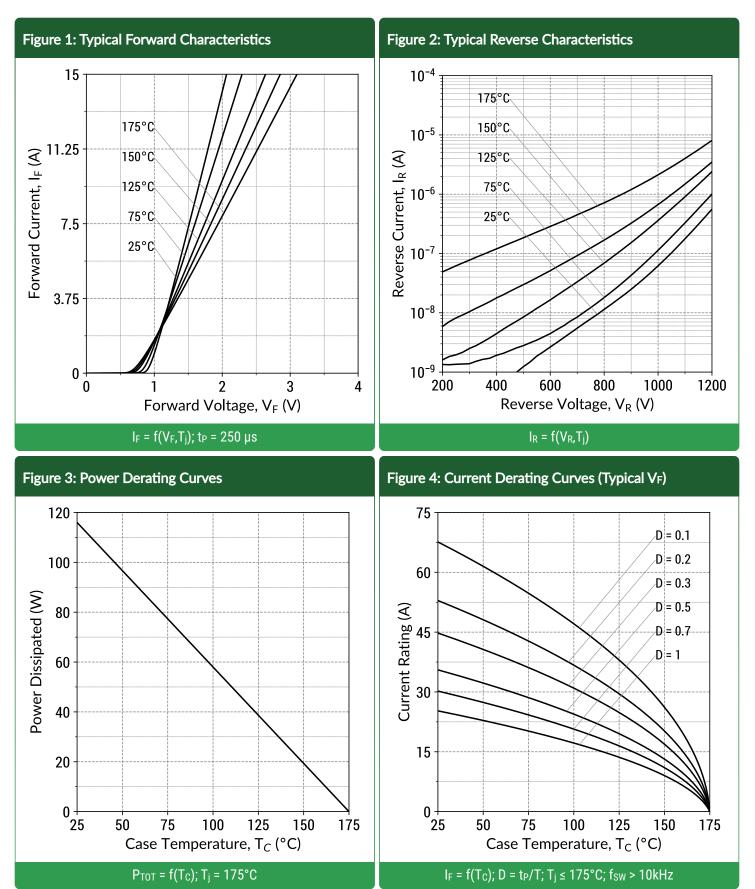
Devemeter	Cymhol	Conditions		Values			11	Nete
Parameter	Symbol			Min.	Typ.	Max.	Unit	Note
Diode Forward Voltage	V _F	I _F = 7.5 A, T _j = 25°C			1.5	1.8	V	Fig. 1
	۷F	I _F = 7.5 A, T _j = 175°C			1.9			
Reverse Current	la la	V _R = 1200 V, T _j = 25°C			1	5	μA	Fig. 2
	I _R	V _R = 1200 V, T _j = 175°C			9		μΑ	
Total Capacitive Charge	Qc		V _R = 400 V		28		nC	Fig. 7
	QC	I _F ≤ I _{F,MAX}	V _R = 800 V		40			
Switching Time	+-	dI _F /dt = 200 A/µs V _R = 400 V			< 10		ns	
	ts		V _R = 800 V		< 10			
Total Capacitance	0	V _R = 1 V, f = 1MHz			457		ъĘ	Fig. 6
	С	V _R = 800 V, f = 1MHz			27		pF	

Thermal/Package Characteristics

Davamatar	Symbol	Conditions	Values			11	Note
Parameter		Conditions	Min.	Typ.	Max.	- Unit	Note
Thermal Resistance, Junction - Case	RthJC			1.29		°C/W	Fig. 9
Weight	WT			2.0		g	
Mounting Torque	T _M	Screws to Heatsink			1.0	Nm	

GC08MPS12-220 1200V 7.5A SiC Schottky MPS[™] Diode



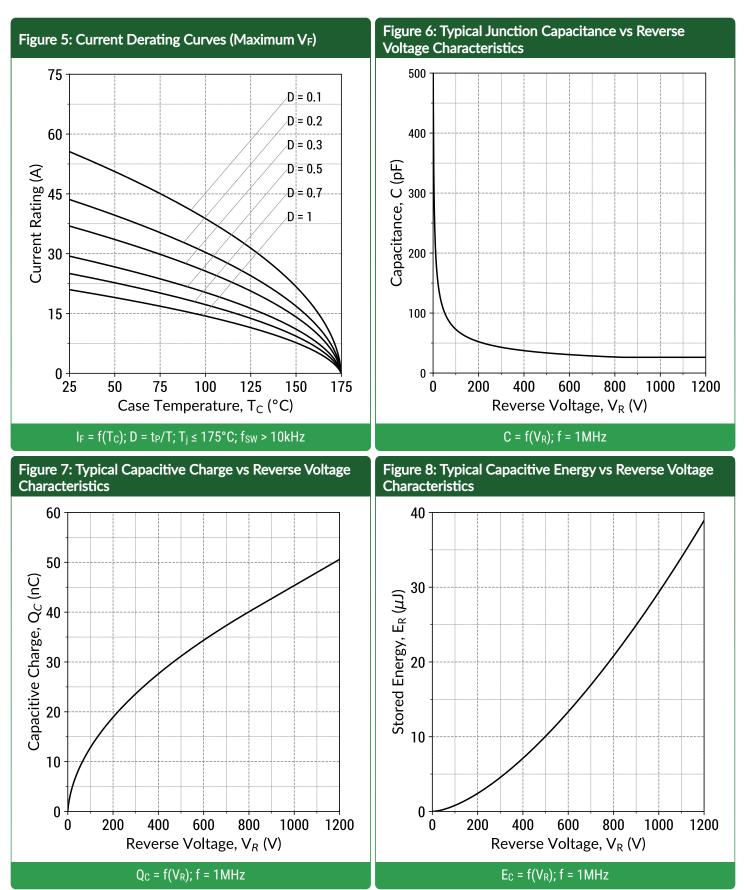


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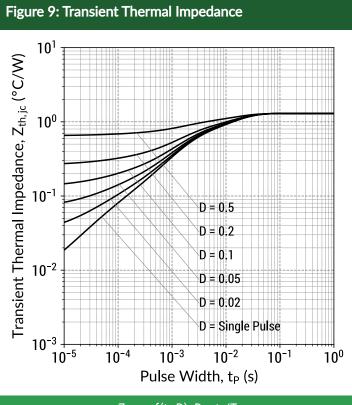
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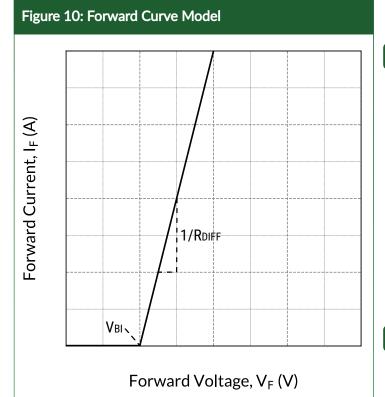




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 $Z_{th,jc} = f(t_P,D); D = t_P/T$



 $I_F = f(V_F, T_j)$

Forward Curve Model Equation:

 $I_F = (V_F - V_{BI})/R_{DIFF} (A)$

Built-In Voltage (V_{BI}):

 $V_{BI}(T_j) = m \times T_j + n (V)$ m = -0.00123 (V/°C) n = 0.995 (V)

Differential Resistance (RDIFF):

 $R_{DIFF}(T_j) = a \times T_j^2 + b \times T_j + c (\Omega)$ a = 1.59e-06 (\Omega/°C²) b = 0.000226 (\Omega/°C) c = 0.0669 (\Omega)

Forward Power Loss Equation:

 $P_{LOSS} = V_{BI}(T_j) \times I_{AVG} + R_{DIFF}(T_j) \times I_{RMS}^2$



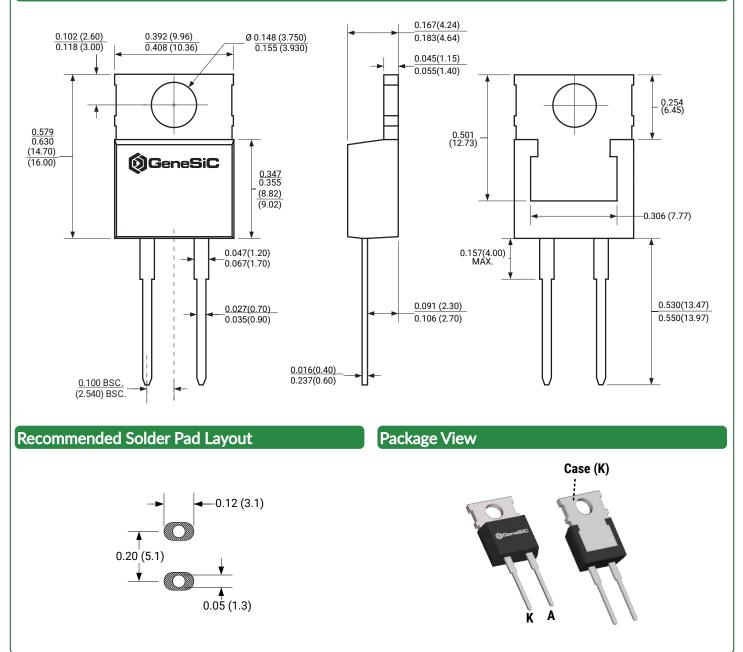
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Package Dimensions

TO-220-2 Package Outline



NOTE

- 1. CONTROLLED DEIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.



RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, or air traffic control systems.

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Related Links

 SPICE Models: 	https://www.genesicsemi.com/sic-schottky-mps/GC08MPS12-220/GC08MPS12-220_SPICE.zip
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